Search Notes

Application/Control	No.	

Applicant(s)/Patent under Reexamination
BASH ET AL.

10/772,318 Examiner

Art Unit

Chen-Wen Jiang

3744

SEARCHED					
Class	Subclass	Date	Examiner		
236	64				
	49.3				
62	180				
	186				
	259.2				
	229 208				
	185 178				
	228.4 229	12/1/2005	Cl		
236 <sup>-</sup>	51				
Search	Updated	5/24/2006	Cl		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
236	51	5/24/2006	Cl		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST Searched Inventor Searched	12/1/2005	cı	
Interference Search Printed	5/24/2006	Cl	